Application/Control No. Applicant(s)/Patent Under Reexamination 10/699,343 TAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1774 Betelhem Shewareged **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2004/0065230 A1 04-2004 Katoh et al. 106/400 Α 428/32.26 US-2004/0037978 A1 02-2004 Tsubaki et al. В С US-D US-US-Ε F US-G US-Н US-US-USj US-Κ Ļ US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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